

Search Notes**Application/Control No.**

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Examiner

Nam Huynh

Applicant(s)/Patent under Reexamination

YOSHIDA ET AL.

Art Unit

2617

SEARCHED

Class	Subclass	Date	Examiner
705	16	3/2/2007	NTH
	26		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See EAST search notes.	3/2/2007	NTH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner